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1. Scope

This specification applied to the products of current sensing resistor of metal foil for Lead-Free RLP series manufactured by TA-I TECHNOLOGY CO.,LTD.

2. Type Designation

RLP 25

 \mathbf{F}

E

 \mathbf{C}

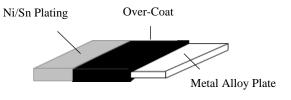
(**M**)

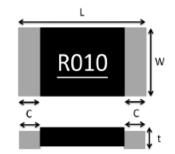
R001

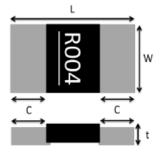
Series No.	Tolerance	Packaging	Power	Metal	Resistance
25: 2512	F= ±1%	E= Embossed	C= 1W	M= MnCu	e.g.
28:2817	G= ±2%		D= 1.5W		$R010=10m\Omega$
45: 4527	J= ±5%		E= 2W		$R001=1m\Omega$
			G= 3W		
			J= 5W		

3. Construction and Dimension

3.1 RLP25







Series	L	W	С	t	Material
RLP25	6.4±0.2	22.02	$2.2\pm0.2(\leq 4\text{m}\Omega)$	0.0.0.20	Strip: Alloy
KLF23	0.4±0.2	3.2±0.2	$0.9\pm0.2 (R>4m\Omega)$	0.9±0.20	Over Coating: polymer Compound UL-94V-0 grade

UNIT: mm



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Marking

For RLP25

(1) If $R \le 4m\Omega$, the marking pattern is as follows.



Resistance value is expressed by 4 digits.

E.G.:

 $R002 = 0.002\Omega = 2m\Omega$

 $R004 = 0.004\Omega = 4m\Omega$

(2) If $R>4m\Omega$, the marking pattern is as follows.



Resistance value is expressed by 4 digits.

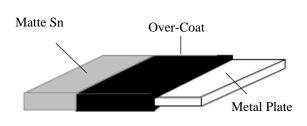
E.G.:

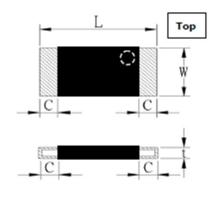
 $R010 = 0.010\Omega = 10 \text{m}\Omega$

 $R020 = 0.020\Omega = 20m\Omega$

*Note: If the marking pattern has underline, it is indicated as a MnCu material

3.2 RLP28





Series	L	W	С	T	Material
RLP28	7.1±0.2	4.2±0.1	0.9±0.2	0.8±0.20	Strip: Alloy Over Coating: Polymer Compound UL-94V-0 grade

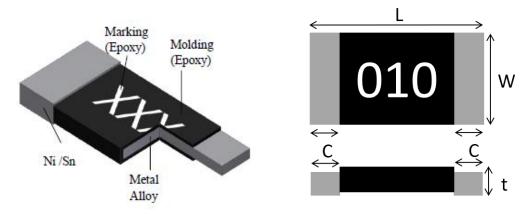
UNIT: mm

Marking For RLP28: No marking



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3.3 RLP45



Series	L	W	С	T
RLP45	11.65±0.25	6.85±0.25	1.85±0.25	1.10±0.25

UNIT: mm

Marking

For RLP45

The marking pattern is as follows.



Resistance value is expressed by 3 digits.

E.G.:

 $010=0.010\Omega=10m\Omega$

 $7.5=0.0075\Omega = 7.5m\Omega$



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4. Features

Туре	*RLP25	RLP25 (MnCu)	RLP28	RLP45
Size	2512	2512	2817	4527
Power Rating	$\begin{array}{c} 1 \text{m}\Omega < \text{R} \leq 100 \text{m}\Omega \\ (1 \text{W} \cdot 1.5 \text{ W} \cdot 2 \text{ W} \cdot 3 \text{W}) \\ 100 \text{m}\Omega < \text{R} \leq 680 \text{m}\Omega \\ (1 \text{W} \cdot 1.5 \text{ W} \cdot 2 \text{ W}) \end{array}$	$ \begin{array}{c} 1 \text{ m}\Omega \leq R \leq 70 \text{m}\Omega \\ (1\text{W} \cdot 1.5 \text{ W} \cdot 2 \text{ W} \cdot 3\text{W}) \end{array} $	5W	5W
Resistance Value	$1 \text{m}\Omega < R \leq 680 \text{m}\Omega$	1~70mΩ	$10 \text{m}\Omega$ / $20 \text{m}\Omega$	5~60mΩ
Operation Temperature Range	-55°C~+170°C			
TCR	±50ppm/°C	±50ppm/°C	±50ppm/°C	±75ppm/°C
Tolerance		±1%, ±2%, ±5%		
Insulation Resistance	Over 100MΩ			
Maximum Working Voltage(V)	$(P*R)^{1/2}$			

Note1: For RLP25, 2&3 watts total Solder pad and trace size of 300 mm²

Thickness does not include protective layer

Note2: For RLP25, 2&3watts, copper foil minimum thickness of PCB : $105\mu m$



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5. Reliability Tests

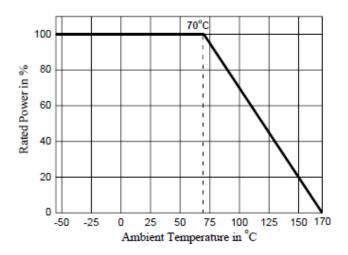
Test Items	Reference	Condition of Test	Test Limits
Temperature Coefficient of Resistance	IEC60115-1 4.8	+25 ~ 125°C	Refer 4.0
High Temperature Exposure (Storage)	AEC-Q200-REV D-Test 3 MIL-STD202 Method 108	T=170°C.1000hrs, Measurement at 24hrs after test conclusion.	< ±1%
Temperature Cycling	AEC-Q200-REV D-Test 4 JESD22 Method JA-104	1000Cycle (-55°C to 125°C), Measurement at 24hrs after test conclusion.	< ±0.5%
Short time overload	IEC60115-1 4.13	5 X rated power for 5s	< ±0.5%
Moisture Resistance	AEC-Q200-REV D-Test 6 MIL-STD-202 Method 106	T=24 hours / Cycle ,10 Cycles. Notes: Steps 7a& 7b not required. Unpowered	< ±1%
Biased Humidity	AEC-Q200-REV D-Test 7 MIL-STD-202 Method 103	10%Rated power at 85°C.RH:85% 1000hrs, Measurement at 24hrs after test conclusion.	< ±0.5%
Operation life	AEC-Q200-REV D-Test 8 MIL-STD-202 Method 108	1000 hours TA=125°C at 45% rated power. Measurement at 24±4 hours after test conclusion.	<±1%
External Visual	AEC-Q200-REV D-Test 9 MIL-STD-883 Method 2009	Electrical test not required. Inspect device construction, marking and workmanship.	
Physical Dimension	AEC-Q200-REV D-Test 10 JESD22 Method JB-100	Verify physical dimensions to the applicable device detail specification. Note: User(s) and Suppliers spec. Electrical test not required.	
Resistance to Solvents	AEC-Q200-REV D-Test 12 MIL-STD-202 Method 215	a: Isopropyl Alcohol: Mineral Spirits = 1:3 b: Terpene Defluxer (Bioact EC-7R) c: Deionized water: Propylene Glycol Monomethyl Ether: monoethanolamine = 42:1:1	Marking and protective layer cannot be detached
Resistance to Soldering Heat	AEC-Q200-REV D-Test 15 MIL-STD-202 Method 210	T=260+/-5°C solder,10+/-1 sec dwell	< ±0.5%
Mechanical Shock	AEC-Q200-REV D-Test 13 MIL-STD-202 Method 213	100g's, Normal duration is 6ms, half sine shock pulse	< ±0.5%
Resistance to vibration	AEC-Q200-REV D-Test 14 MIL-STD-202 Method 204	5g's for 20min.12cycles, 10-2000Hz	<±0.5%
Board Flex	AEC-Q200-REV D-Test 21 AEC-Q200-005	Min 2mm deflection ,60sec.	< ±0.5%
Flammability	AEC-Q200-REV D-Test 20 UL-94	V-0 or V-1are acceptable, Electrical test not required	V-0
Thermal Shock	AEC-Q200-REV D-Test 16 MIL-STD-202 Method 107	-55°C/+155°C. Note: Number of cycles required-300, Maximum transfer time-20 seconds, Dwell time-15 minutes. Air-Air.	< ±1.0%



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ESD	AEC-Q200-REV D-Test 17 AEC-Q200-002 or ISO/DIS 10605	verify the voltage setting at 500V	< ±1.0%
Solderability	AEC-Q200-REV D-Test 18 J-STD-002	Method B, aging 4 hours at 155 °C dry heat Lead-free solder bath at 235±3 °C Dipping time: 3±0.5 seconds	> 95% area covered with tin
Terminal Strength (SMD)	AEC-Q200-REV D-Test 22 AEC-Q200-006	Force of 1.8kg for 60 seconds Remarks: 0201-NA	< ±1.0%

5.1 Derating Curve



5.2 Rated Current

The rated current is calculated by the following formula:

 $I = \sqrt{\mathbf{P} \div \mathbf{R}}$

I: Rated Current (A)

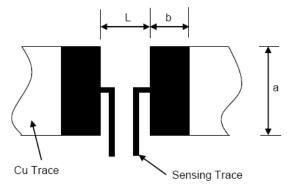
P: Rated Power (W)

R: Resistance Value (Ω)



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6. Recommended Solder Pad Dimension



Type	Resistance Range(m Ω)	a	b	L
RLP25	R >4	4.0±0.1	2.1±0.1	4.1±0.1
KLP25	R≦4	4.0±0.1	3.1±0.1	1.3±0.1
RLP28	10~20	5.0±0.1	2.4±0.1	5.2±0.1
RLP45	$5 \leq R \leq 60$	8.0±0.1	4.0±0.1	7.6±0.1

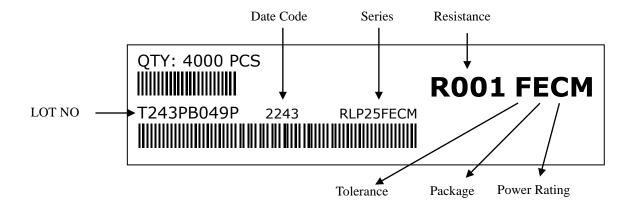
Note: *The copper foil minimum thickness of PCB needs 3 oz

Unit: mm

7. Number of Package

	RLP25	RLP28	RLP45
Pieces	4000	2000	2000

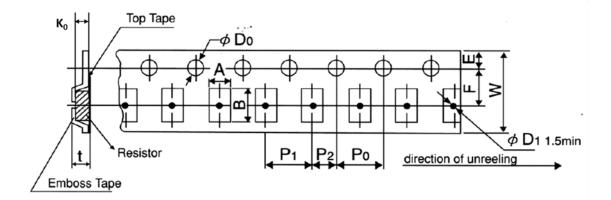
8. Label



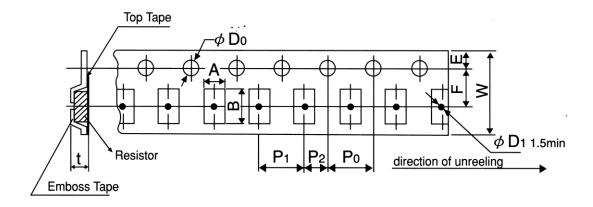


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9. Packaging



Packing	Type	A	В	W	F	Е	P_1	P ₂	P_0	$\phi\mathrm{D}_0$	t	K_0
Emboss	RLP25	3.6	6.9	12	5.5	1.75	4.0	2.0	4.0	ψ 1.5	1.2	1.0
Tape		±0.2	±0.2	±0.2	±0.05	±0.1	±0.1	±0.05	±0.05	(+0.1/-0)	±0.15	±0.15



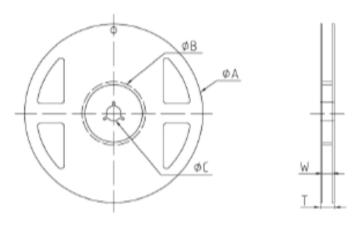
Packing	Type	Α	В	W	F	Е	P_1	P_2	P_0	D_0	t
Emboss	RLP28	4.5 ±0.2	7.4 ±0.2	12 ±0.2	5.5 ±0.05	1.7 ±0.1	8.0 ±0.1	2.0 ±0.05	4.0 ±0.05	ψ1.5 (+0.1/-0)	0.85 ±0.15
Tape	RLP45	7.30 ±0.10	11.90 ±0.10	24.0 ±0.20	11.50 ±0.10	1.75 ±0.10	12.0 ±0.10	2.0 ±0.10	4.0 ±0.10	ψ1.55 ±0.10	1.3 ±0.10

UNIT: mm



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10. Reel Specification

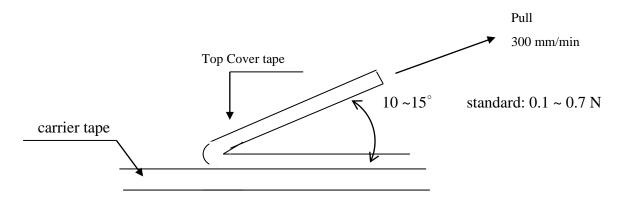


Series	ϕ A	ϕ B	ϕ C	W	T
RLP25	180(+0/-3)	60.0 ±1.0	13.0 ±1.0	13.0 ±1.0	15.4 ±2.0
RLP28	180(+0/-3)	60.0 ±1.0	13.0 ±1.0	13.0 ±1.0	15.4 ±2.0
RLP45	350.0 ±2.0	60.0 ±1.0	13.0 ±1.0	25.0 ±1.0	27.4±1.0

Unit: mm

11. Peeling Strength of Top Cover Tape

Test Condition: 0.1 to 0.7 N at a peel-off speed of 300 mm $\!/$ min.



12. Storage Conditions

Temperature: 5°C~35°C, Humidity:40%~75%

Humidity storage level: Level 1

13. Shelf Life

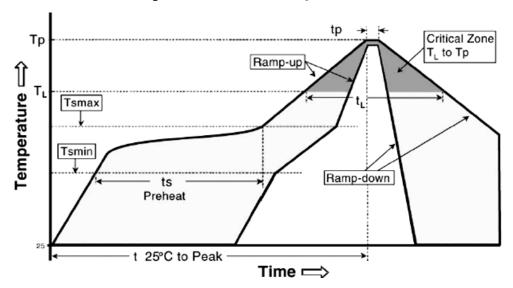
2 years from manufacturing date.

TA-I TECHNOLOGY CO., LTD



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14. Recommend IR – Reflow profile (solder: Sn96.5 / Ag3 / Cu0.5)



Alloyed Re-flow times: 3 times

Remark: To avoid discoloration phenomena of chip on terminal electrodes,

please use N2 Re-flow furnace.

Iron Solder:350±10°C, 3+1/-0 sec,1 time

Profile Feature	Lead (Pb)-Free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C / second max
Preheat - Temperature Min (Tsmin) - Temperature Max (Tsmax) - Time (Tsmin to Tsmax) (ts)	150°C 200°C 60 -120 seconds
Time maintained above - Temperature (TL) - Time (TL)	217°C 60-150 seconds
Peak Temperature (Tp)	260°C
Time within +0/-5°C of actual Peak Temperature (tp) ²	10 seconds
Ramp-down Rate	6°C/second max.
Time 25°C to Peak Temperature	8mimutes max.



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15. ECN

Engineering Change Notice: The customer will be informed with ECN if there is significant modification on the characteristics and materials described in Approval Sheet.

16. Manufacturing Country & City

TA-I TECHNOLOGY CO., LTD. (Taiwan- Tao Yuan)

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Associated companies

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(3) FORTUNE TASK RESISTOR FACTORY (China – Dongguan)

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(4)TAI OHM ELECTRONICS (M) SDN. BHD. (Malaysia –Penang)

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单击下面可查看定价,库存,交付和生命周期等信息

>>TA-I(大毅)